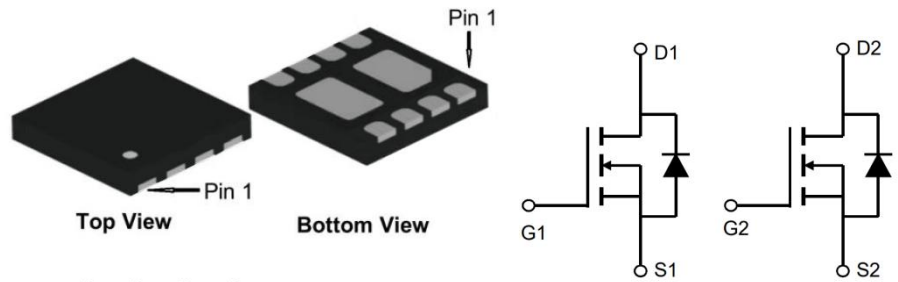




## Dual N-Channel Enhancement Mode MOSFET

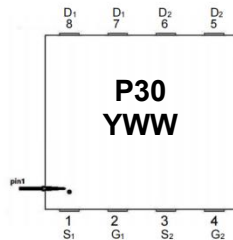
### Features

- Advanced SGT MOS technology
- Low Thermal Resistance
- Low Gate Charge
- Fast Switching Speed



### Application

- Load Switch
- DC-DC converters
- Load Switch for Portable Devices
- Voltage controlled small signal switch



DFN2020B-8L  
 Marking: P30  
 Data Code: YWW

### Single N-Channel MOS Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified )

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	100	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	8	A
Peak Drain Current, Pulsed <sup>1)</sup>	I <sub>DM</sub>	28	A
Single Pulse Avalanche Energy <sup>2)</sup>	E <sub>AS</sub>	8	mJ
Power Dissipation	T <sub>C</sub> =25°C P <sub>tot</sub>	13	W
Operating Junction	T <sub>J</sub>	-55~150	°C
Storage Temperature Range	T <sub>stg</sub>	-55~150	°C

### Thermal Characteristics

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Case	R <sub>θJC</sub>	9	°C/W

Note:

- 1) Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub> = 150°C.
- 2) Limited by T<sub>J(MAX)</sub>, starting T<sub>J</sub> = 25 °C, L = 0.1mH, R<sub>G</sub> = 25 Ω, V<sub>GS</sub> = 10 V.
- 3) Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

**Single N-Channel MOS Characteristics at  $T_a = 25^\circ\text{C}$  unless otherwise specified**

Parameter	Symbol	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>					
Drain-Source Breakdown Voltage at $I_D = 250 \mu\text{A}$	$BV_{DSS}$	100			V
Drain-Source Leakage Current at $V_{DS} = 100 \text{ V}$	$I_{DSS}$			1	$\mu\text{A}$
Gate Leakage Current at $V_{GS} = \pm 20 \text{ V}$	$I_{GSS}$			$\pm 100$	nA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	$V_{GS(th)}$	2.2		3.8	V
Drain-Source On-State Resistance at $V_{GS} = 10 \text{ V}$ , $I_D = 10 \text{ A}$	$R_{DS(on)}$		75	90	m $\Omega$
<b>DYNAMIC PARAMETERS</b>					
Input Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{iss}$		520		pF
Output Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{oss}$		40		pF
Reverse Transfer Capacitance at $V_{GS} = 0 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{rss}$		2.4		pF
Gate charge total at $V_{DS} = 50 \text{ V}$ , $I_D = 12 \text{ A}$ , $V_{GS} = 10 \text{ V}$	$Q_g$		6		nC
Gate to Source Charge at $V_{DS} = 50 \text{ V}$ , $I_D = 12 \text{ A}$ , $V_{GS} = 10 \text{ V}$	$Q_{gs}$		1.1		nC
Gate to Drain Charge at $V_{DS} = 50 \text{ V}$ , $I_D = 12 \text{ A}$ , $V_{GS} = 10 \text{ V}$	$Q_{gd}$		1.3		nC
Turn-On Delay Time at $V_{GS} = 10 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $I_D = 10 \text{ A}$ , $R_g = 6 \Omega$	$t_{d(on)}$		16.2		nS
Turn-On Rise Time at $V_{GS} = 10 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $I_D = 10 \text{ A}$ , $R_g = 6 \Omega$	$t_r$		3.2		nS
Turn-Off Delay Time at $V_{GS} = 10 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $I_D = 10 \text{ A}$ , $R_g = 6 \Omega$	$t_{d(off)}$		13		nS
Turn-Off Fall Time at $V_{GS} = 10 \text{ V}$ , $V_{DS} = 50 \text{ V}$ , $I_D = 10 \text{ A}$ , $R_g = 6 \Omega$	$t_f$		22		nS
<b>Body-Diode PARAMETERS</b>					
Drain-Source Diode Forward Voltage at $I_S = 20 \text{ A}$ , $V_{GS} = 0 \text{ V}$	$V_{SD}$			1.3	V
Body Diode Reverse Recovery Time at $I_S = 10 \text{ A}$ , $di/dt = 100 \text{ A} / \mu\text{s}$	$t_{rr}$		45		nS
Body Diode Reverse Recovery Charge at $I_S = 10 \text{ A}$ , $di/dt = 100 \text{ A} / \mu\text{s}$	$Q_{rr}$		63		nC



### Electrical Characteristics Curves

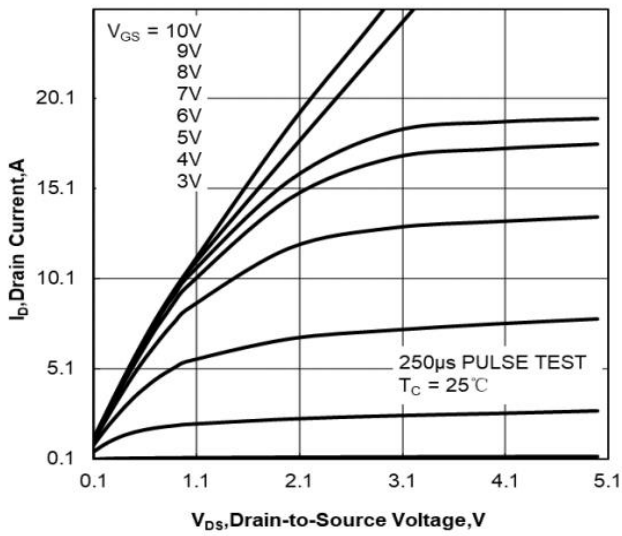


Figure 1. Output Characteristics

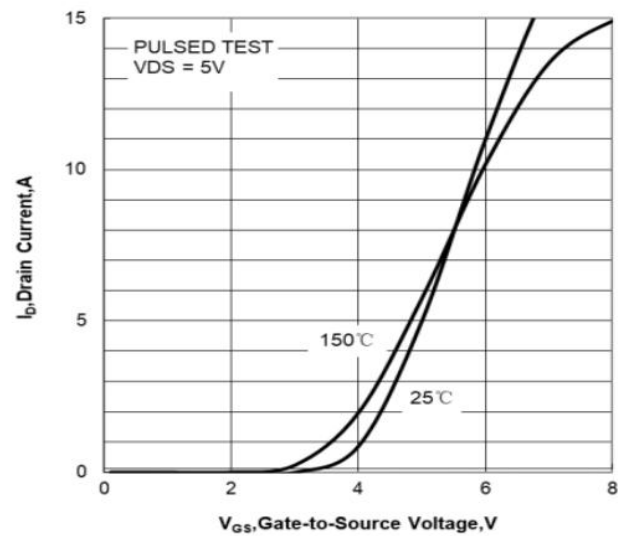


Figure 2. Transfer Characteristics

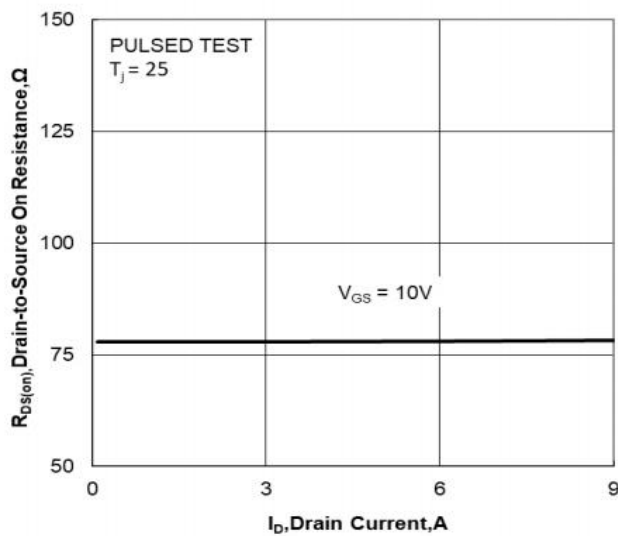


Figure 3. Drain-to-Source On Resistance vs Drain Current

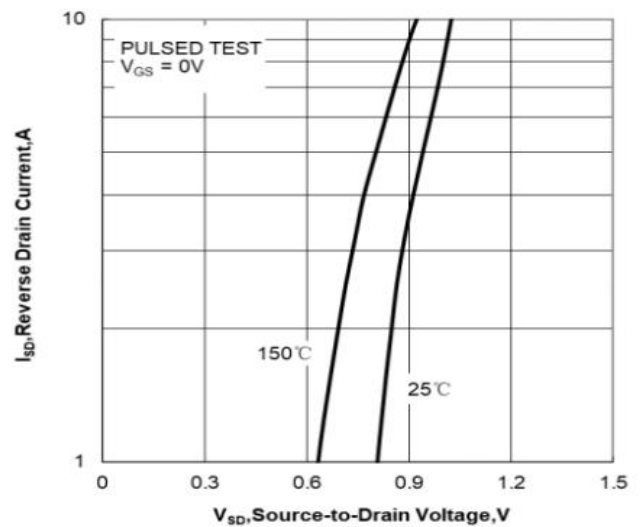
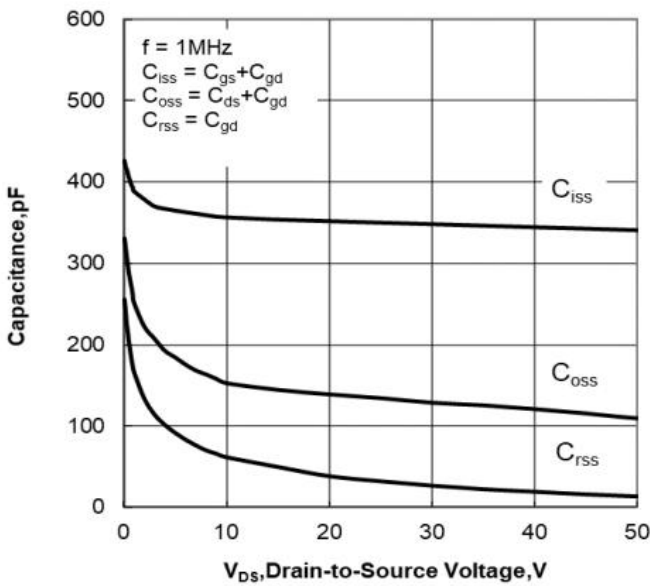


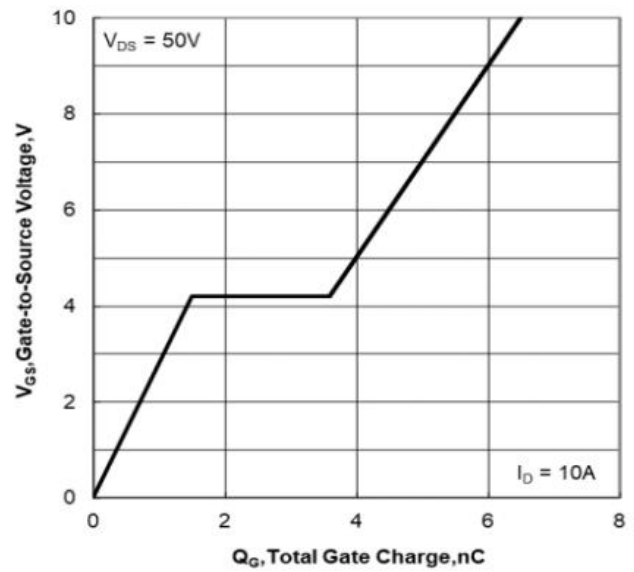
Figure 4. Body Diode Forward Voltage vs Source Current and Temperature



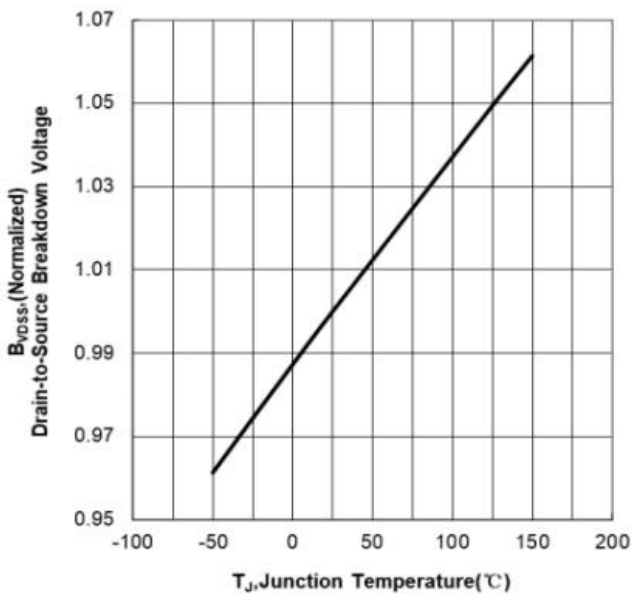
**Electrical Characteristics Curves**



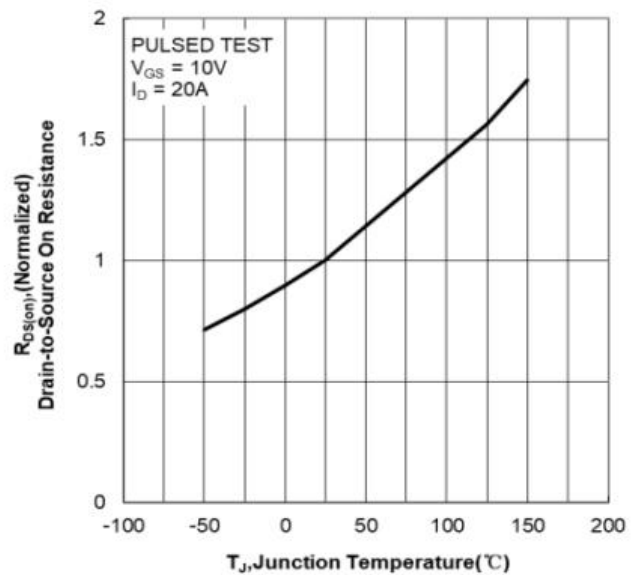
**Figure 5. Capacitance Characteristics**



**Figure 6. Gate Charge Characteristics**



**Figure 7. Normalized Breakdown Voltage vs Junction Temperature**



**Figure 8. Normalized On Resistance vs Junction Temperature**



Electrical Characteristics Curves

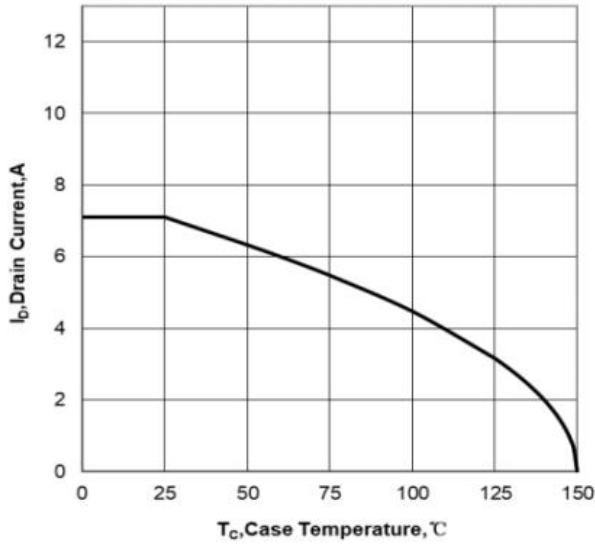


Figure 9. Maximum Continuous Drain Current vs Case Temperature

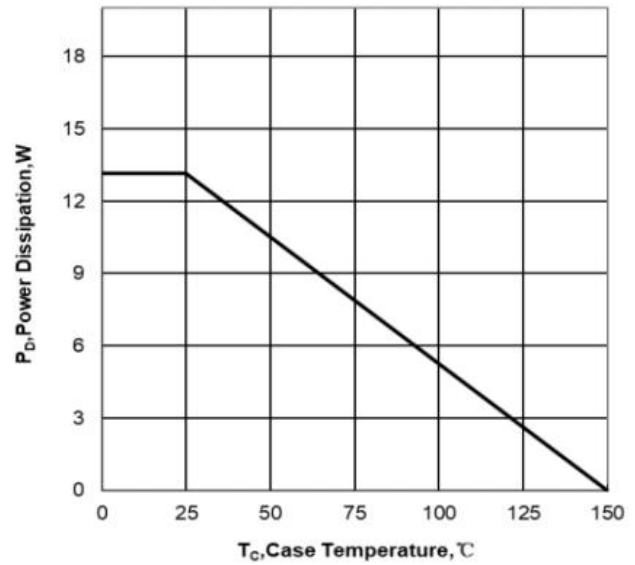


Figure 10. Maximum Power Dissipation vs Case Temperature

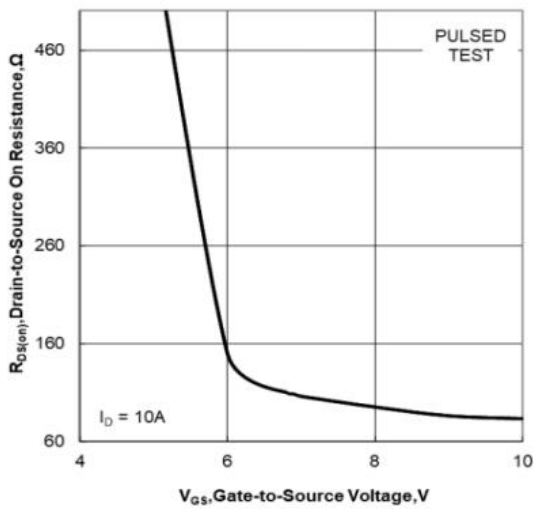


Figure 11. Drain-to-Source On Resistance vs Gate Voltage and Drain Current

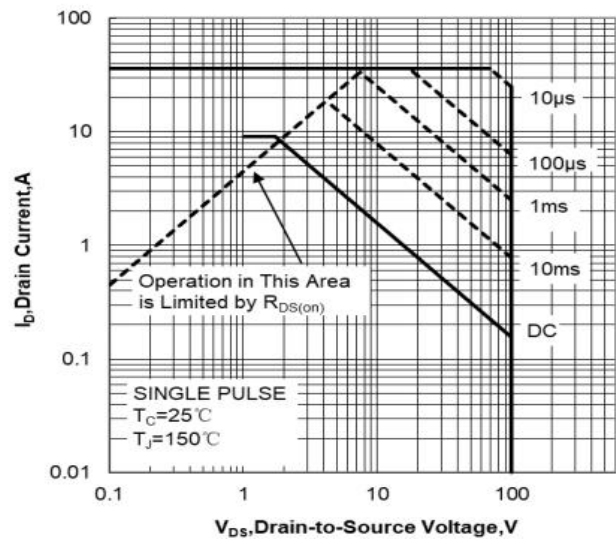


Figure 12. Maximum Safe Operating Area



Test Circuits

Fig.1-1 Switching times test circuit

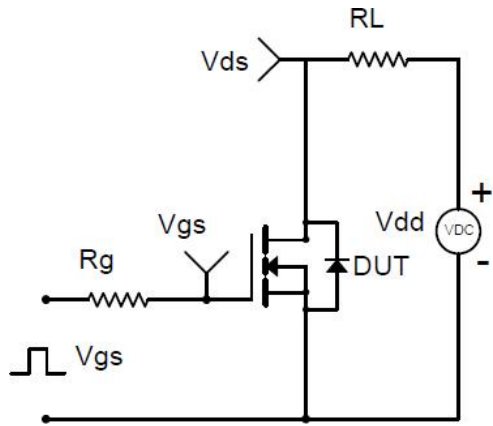


Fig.1-2 Switching Waveform

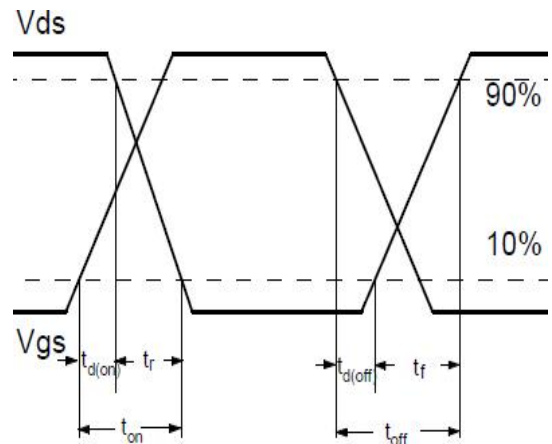


Fig.2-1 Gate charge test circuit

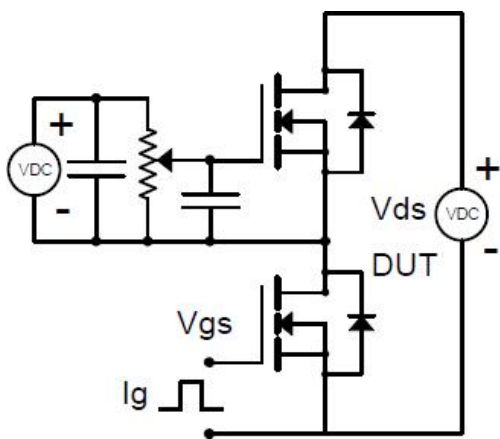


Fig.2-2 Gate charge waveform

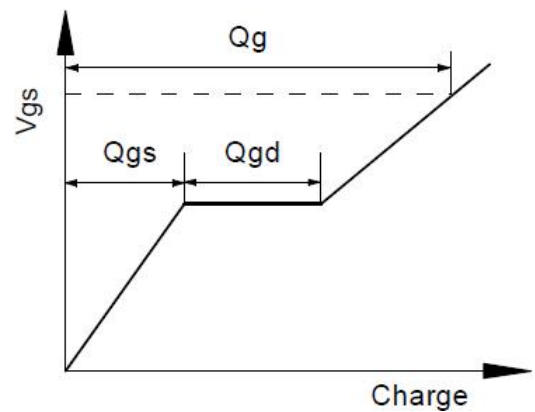


Fig.3-1 Avalanche test circuit

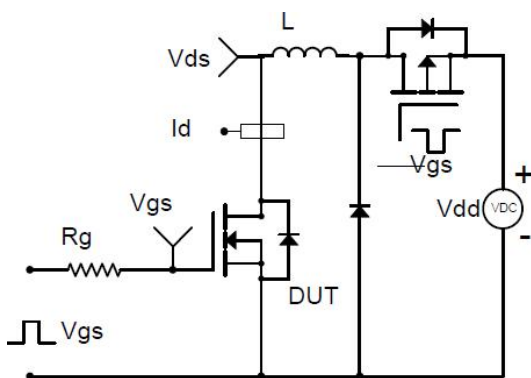
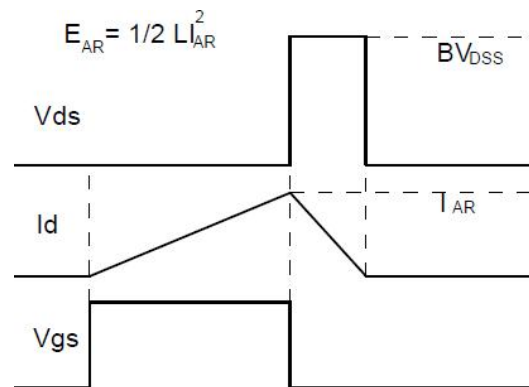


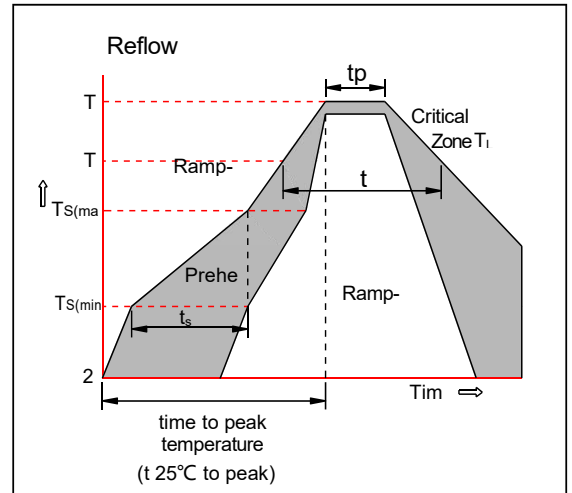
Fig.3-2 Avalanche waveform





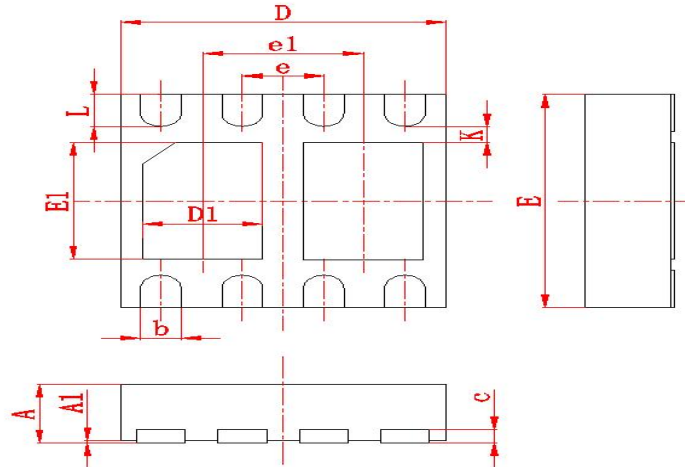
**Soldering parameters**

Reflow Condition		Pb-Free assembly (see as below)
Pre Heat	-Temperature Min ( $T_{s(min)}$ )	+150°C
	-Temperature Max( $T_{s(max)}$ )	+200°C
	-Time (Min to Max) (ts)	60-180 secs.
Average ramp up rate (Liquid us Temp ( $T_L$ ) to peak)		3°C/sec. Max
$T_{s(max)}$ to $T_L$ - Ramp-up Rate		3°C/sec. Max
Reflow	-Temperature( $T_L$ )(Liquid us)	+217°C
	-Temperature( $t_L$ )	60-150 secs.
Peak Temp ( $T_p$ )		+260(+0/-5)°C
Time within 5°C of actual Peak Temp ( $t_p$ )		30 secs. Max
Ramp-down Rate		6°C/sec. Max
Time 25°C to Peak Temp ( $T_p$ )		8 min. Max
Do not exceed		+260°C



**Package Outline Dimensions (Units: mm)**

**DFN2020B-8L**



符号	尺寸		符号	尺寸		符号	尺寸	
	Min	Max		Min	Max		Min	Max
A	0.5	0.6	E	1.9	2.1	e1	(0.99)	
A1	0	0.05	E1	1.0	1.2	b	0.2	0.3
D	1.9	2.1	K	(0.15)		c	(0.127)	
D1	0.69	0.79	e	(0.5)		L	0.25	0.35